

# Extending Leeson's Equation

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**Abstract:** The oscillator phase noise is one of the key limitations in several fields of electronics. An electronic oscillator phase noise is usually described by the Leeson's equation. Since the latter is frequently misinterpreted and misused, a complete derivation of the Leeson's equation in modern form is given first. Second, effects of flicker noise and active-device bias are accounted for. Next the complete spectrum of an electronic oscillator is derived extending the result of the Leeson's equation into a Lorentzian spectral line. Finally the spectrum of more complex oscillators including delay lines is calculated, like opto-electronic oscillators.

**Keywords:** phase noise; Leeson's equation; oscillator bias; Lorentzian line; opto-electronic oscillator

## Razširitev Leesonove Enačbe

**Izvilleček:** Fazni šum oscilatorja je ena ključnih omejitev v številnih področjih elektronike. Fazni šum elektronskega oscilatorja običajno opisuje Leesonova enačba. Ker je slednja pogosto slabo razumljena in napačno uporabljena, bo najprej opisana celotna izpeljava Leesonove enačbe. V drugem koraku je nujna obravnava učinkov šuma  $1/f$  in nastavitve delovne točke aktivnega gradnika. Sledi celovita izpeljava spektra elektronskega oscilatorja, ki rezultat Leesonove enačbe razširi v Lorentzovo spektralno črto. Končno se izpelje spekter bolj kompliciranih oscilatorjev, kot so to opto-elektronski oscilatorji.

**Ključne besede:** fazni šum; Leesonova enačba; delovna točka oscilatorja; Lorentzova črta; opto-elektronski oscilator

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## Introduction

Towards the end of the 19<sup>th</sup> century, the Hertz experiments connected two areas of physics, namely electricity and optics. While radio communications started with filtered noise from spark gaps, the latter were quickly replaced by much more efficient vacuum-tube electronic oscillators, invented independently by Armstrong and Meissner around 1912.

Electronic oscillators were so successful that their spectrum was considered an infinitely narrow spectral line at relatively low radio frequencies  $f < 30\text{ MHz}$  in the first half of the 20<sup>th</sup> century. Their spectral line was only broadened by external causes like unfiltered supply, load pull, temperature drift and/or vacuum-tube aging.

On the other hand, in optics it was quickly discovered that spectral lines of different light sources were not infinitely narrow. The optical line width  $\Delta\lambda_0$  or  $\Delta f$  could be measured with (relatively simple) interferometers and expressed as longitudinal coherence length  $d$  in free space  $c_0$  :

$$d \approx \frac{c_0}{\Delta f} \approx \frac{\lambda_0^2}{\Delta \lambda_0} \quad (1)$$

Unfortunately the amplitude dynamic range of simple optical instruments was quite limited.

In the second half of the 20<sup>th</sup> century, both the frequency resolution of radio measurements as well as the amplitude dynamic range of optical measurements improved by several orders of magnitude. Both keep improving as the user requests keep increasing. Last but not least, the spectrum gap between radio and optics is shrinking as radio frequencies are increasing towards the terahertz region and optical wavelengths are increasing towards the far-infrared region.

One of the most important contributions is the derivation of the oscillator noise spectrum by David Leeson in 1966 [1]. The same derivation is applicable to (relatively low) radio-frequency electronic oscillators as well as to lasers. In electronics, high-performance oscillators are followed by buffer stages that may add their own noise. Electronic limiters may reduce the amplitude noise but they have no effect on the phase noise.

The design of a performing radio-frequency oscillator is complex. Besides basic radio-frequency design the knowledge of different noise contributions is required as well as the knowledge of feedback theory. Due to this complexity the Leeson's equation is frequently misunderstood, misused and even degraded to an "empirical" equation by some sources. The term phase noise only starts appearing in equipment specifications as well as in text books in the 21<sup>st</sup> century as it is becoming the limiting parameter for increasingly complex modulation schemes at ever increasing carrier frequencies.

## Electronic oscillator

An electronic oscillator includes an amplifier with a voltage gain  $A$  and a feedback network with a voltage transfer function  $H(\omega)$ . The feedback network is usually a frequency-selective resonator to define the output spectrum of the oscillator:

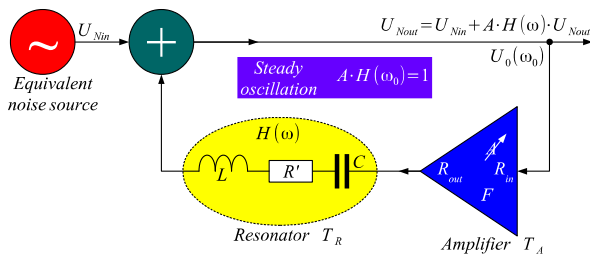


Figure 1: Electronic oscillator.

For the circuit to oscillate, the Barkhausen criterion applies:

$$A \cdot H(\omega_0) = 1 \quad (2)$$

The Barkhausen criterion is an equation with complex numbers defining both the phase and the magnitude of the feedback. The circuit can only oscillate at the frequency  $\omega_0$  where the feedback phase is zero or an integer multiple of  $2\pi$ . The amplifier should provide enough gain  $A$  to start the oscillation. During steady oscillation, saturation will eventually decrease the amplifier gain  $A$  to satisfy the Barkhausen criterion.

Some feedback networks may generate complex results. A laser may oscillate at many different

modes at the same time. Some electronic circuits may satisfy the Barkhausen criterion at zero frequency. Such circuits do not oscillate but act as bi-stables. A flip-flop intentionally driven into a meta-stable state will quickly settle into one of its two stable states.

Some form of noise is always present in all circuits. In electronic circuits operating in the radio-frequency range, the main contribution is thermal noise. No matter how small, noise will always significantly affect the output spectrum of an oscillator as shown later in the derivation of the Leeson's equation.

In the case of a class A amplifier, noise actually starts the oscillation:

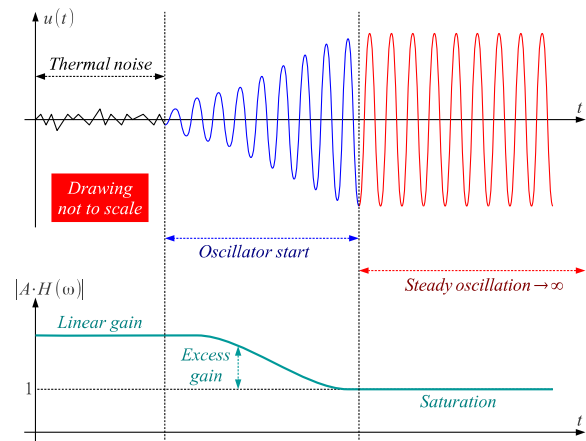


Figure 2: Oscillator start.

With some excess gain, the oscillation amplitude will initially grow exponentially out of noise. As the oscillation amplitude increases, the amplifier will be driven into saturation. The excess gain shrinks and finally reaches the Barkhausen criterion during steady oscillation.

Some oscillators use a class C amplifier. Such oscillators can not start out of noise, but need a start pulse. Unfortunately, after reaching steady oscillation, class C amplifiers add even more noise than class A amplifiers.

## Leeson's equation

The Leeson's equation [1] describes how noise propagates through the circuit of an oscillator. The derivation below refers to Fig. 1:

$$U_{Nout} = U_{Nin} + A \cdot H(\omega) \cdot U_{Nout} \quad (3)$$

can be rearranged to:

$$U_{Nout} = \frac{U_{Nin}}{1 - A \cdot H(\omega)} \quad (4)$$

A simple resonator with a lumped capacitor  $C$  and a lumped inductor  $L$  with losses  $R'$

provides the following transfer function of the feedback:

$$H(\omega) = \frac{R_{in}}{R_{in} + j\omega L + R' + \frac{1}{j\omega C} + R_{out}} \quad (5)$$

During steady oscillation the Barkhausen criterion simplifies the transfer function for small signals  $U_{Nout} \ll U_0(\omega_0)$  compared to the carrier to:

$$A \cdot H(\omega) = \frac{\sum R}{\sum R + j\omega L + \frac{1}{j\omega C}} \quad (6)$$

where the sum of resistors denotes:

$$\sum R = R_{in} + R' + R_{out} \quad (7)$$

The transfer function can be further simplified by introducing the loaded quality  $Q_L$  of the resonator:

$$Q_L = \frac{\omega_0 L}{\sum R} \quad (8)$$

and the frequency offset from the carrier  $\omega_0$  :

$$\Delta\omega = \omega - \omega_0 = \omega - \frac{1}{\sqrt{LC}} \quad (9)$$

into:

$$A \cdot H(\omega) \approx \frac{1}{1 + j2Q_L \frac{\Delta\omega}{\omega_0}} \quad (10)$$

resulting in:

$$U_{Nout} \approx \frac{U_{Nin}}{1 - \frac{1}{1 + j2Q_L \frac{\Delta\omega}{\omega_0}}} \rightarrow$$

$$\rightarrow U_{Nout} \approx U_{Nin} \cdot \left(1 + \frac{\omega_0}{j2Q_L \Delta\omega}\right) \quad (11)$$

Dealing with noise is easier with average signal powers  $P_j = \alpha |U_j|^2$  rather than voltages. The resulting propagation of noise power is:

$$P_{Nout} \approx P_{Nin} \cdot \left[1 + \left(\frac{\omega_0}{2Q_L \Delta\omega}\right)^2\right] \quad (12)$$

In engineering it is also preferred to replace angular frequencies  $\omega_j = 2\pi f_j$  with ordinary frequencies:

$$P_{Nout} \approx P_{Nin} \cdot \left[1 + \left(\frac{f_0}{2Q_L \Delta f}\right)^2\right] \quad (13)$$

The oscillator noise includes both amplitude noise and phase noise. Both have equal power:

$$P_{NA} = P_{N\phi} = \frac{P_{Nout}}{2} \approx \frac{P_{Nin}}{2} \cdot \left[1 + \left(\frac{f_0}{2Q_L \Delta f}\right)^2\right] \quad (14)$$

Since the amplitude noise  $P_{NA}$  can be removed easily with an electronic limiter, only the phase-noise power  $P_{N\phi}$  is interesting.

In electronics, noise is usually referred to the input of an amplifier although it can only be measured on its output. Therefore for compatibility all quantities on Fig. 1 are referred to the amplifier input. The thermal-noise spectral density  $dP_{Nin}/df$  at the amplifier input is equal to the sum of the temperatures of all noise sources multiplied by the Boltzmann constant  $k_B \approx 1.38 \cdot 10^{-23} \text{ J/K}$  :

$$\frac{dP_{Nin}}{df} = k_B \cdot \sum T_j = k_B \cdot (T_R + T_A) \quad (15)$$

The resonator temperature  $T_R \gg T_0 = 290 \text{ K}$  may be much higher than the reference temperature in the case of resonators using active circuits. The noise temperature of a passive resonator is usually close to the reference (room) temperature  $T_R \approx T_0 = 290 \text{ K}$  . In this case the thermal-noise spectral density can be rewritten using the amplifier noise figure  $F$  (in linear units!):

$$\frac{dP_{Nin}}{df} \approx k_B \cdot T_0 \cdot F \quad (16)$$

Note that the amplifier noise figure  $F$  will be higher in saturation (steady oscillation) than in linear operation!

The phase-noise spectral density of an oscillator becomes:

$$\frac{dP_{N\phi}}{df} = \frac{1}{2} \cdot \left[1 + \left(\frac{f_0}{2Q_L \Delta f}\right)^2\right] \cdot k_B T_0 F \quad (17)$$

Since the oscillator output is amplified, limited and/or attenuated, the important quantity is the phase-noise spectral density relative to the oscillator output power  $P_0$  :

$$L(\Delta f) = \frac{1}{P_0} \cdot \frac{dP_{N\phi}}{df} \quad (18)$$

The relative phase-noise spectral density is denoted by the symbol  $L(\Delta f)$  and has units  $[\text{Hz}^{-1}]$  in the Leeson's equation:

$$L(\Delta f) = \left[1 + \left(\frac{f_0}{2Q_L \Delta f}\right)^2\right] \cdot \frac{k_B T_0 F}{2P_0} \quad (19)$$

Due to the extremely wide dynamic range of  $L(\Delta f)$  it is common to use logarithmic units, namely decibels relative to the carrier per unit bandwidth or  $[\text{dBc/Hz}]$  :

$$L(\Delta f)_{[\text{dBc/Hz}]} = 10 \log_{10} [L(\Delta f) \cdot 1 \text{ Hz}] \quad (20)$$

Unfortunately many popular sources like [2] forget to multiply  $L(\Delta f)$  in linear units with the unit

bandwidth 1 Hz , degrading the Leeson's equation to an empirical equation.

As an example, the spectrum of a typical oscillator is computed on Fig. 3 using the Leeson's equation. The carrier power is selected as  $P_0=0.1\text{ mW}$  typical at the input of a small-signal RF transistor. The noise figure degradation is comparable to the gain compression due to saturation, therefore  $F=10\text{ dB}$  is a reasonable choice. The most important parameter of an oscillator, the loaded quality of the resonator is selected  $Q_L=10$  corresponding to a varactor-tuned microstrip resonator at  $f_0=3\text{ GHz}$  :

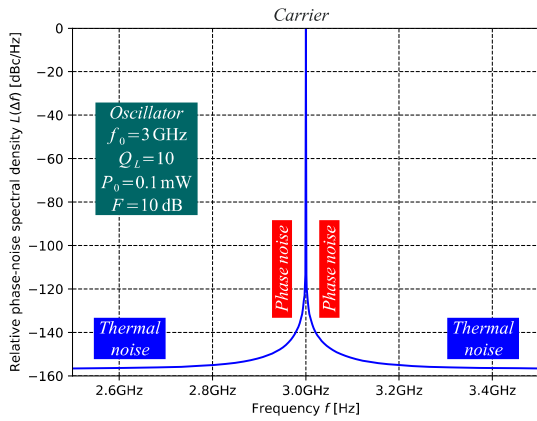


Figure 3: Oscillator spectrum.

The propagation of noise through an oscillator increases the phase noise close to the desired carrier well above the thermal noise. Since the two noise side-bands are symmetric, it makes sense to observe a single side band in detail using a logarithmic scale for the frequency offset  $\Delta f$  from the carrier as shown on Fig. 4:

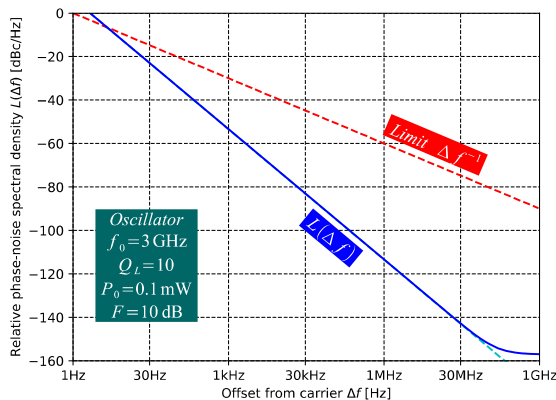


Figure 4: SSB phase-noise spectrum.

At frequency offsets  $|\Delta f| > f_0/(2Q_L)$  larger than the Leeson's frequency, the oscillator has little effect on the noise spectral density. Other circuits like buffer amplifiers, limiters and/or attenuators add their own thermal noise. If required, this

thermal noise can easily be filtered away using resonators with a similar  $Q_L$  as used in the oscillator itself.

At frequency offsets  $|\Delta f| < f_0/(2Q_L)$  smaller than the Leeson's frequency, the predominant noise is the oscillator phase noise. Other circuits like amplifiers, limiters and/or attenuators have little effect on the phase-noise spectral density. The oscillator phase noise can NOT be filtered away using resonators with a similar  $Q_L$  as used in the oscillator itself.

Since the oscillator phase-noise is the interesting quantity, a simplified Leeson's equation neglecting thermal noise is frequently used:

$$L(\Delta f) \approx \left( \frac{f_0}{Q_L \Delta f} \right)^2 \cdot \frac{k_B T_0 F}{8 P_0} \quad (21)$$

The result of the simplified Leeson's equation is shown with a dotted line on Fig. 4. There is a significant difference from the full equation only at large offsets  $|\Delta f| > f_0/(2Q_L) \approx 150\text{ MHz}$  (in the example shown on Fig. 3 and Fig. 4).

The Leeson's equation was derived assuming that the noise amplitude  $U_{\text{Nout}} \ll U_0(\omega_0)$  is much smaller than the desired-carrier amplitude. This assumption no longer holds at small offsets  $\Delta f$ . The Leeson's equation only holds when the relative phase-noise spectral density is much smaller than the  $L(\Delta f) \ll \Delta f^{-1}$  limit shown with a dotted line on Fig. 4. In practice, the result on Fig. 4 is only valid at offsets above  $\Delta f > 1\text{ kHz}$ .

The relative phase-noise density at very small offsets  $\Delta f$  is usually not very important in practical electronic oscillators. It is much more important in laser oscillators. A corrected derivation of the Leeson's equation for very small offsets  $\Delta f$  will be presented later.

## Effects of phase noise

Phase noise was first noted as residual frequency modulation in analog radio links. The unwanted random frequency deviation (root-mean-square value) can be calculated as:

$$\sigma_f = \sqrt{2 \int_{f_{\text{MIN}}}^{f_{\text{MAX}}} \Delta f^2 L(\Delta f) d\Delta f} \quad (22)$$

The frequency limits  $f_{\text{MIN}}$  and  $f_{\text{MAX}}$  of the integral are the band limits of the analog base-band modulation signal.

In QAM radio links, phase noise randomly rotates the constellation of the modulation. The unwanted

random angle of rotation (root-mean-square value) can be calculated as:

$$\sigma_{\phi} = \sqrt{2 \int_{B_{\text{carrier-recovery}}}^{B_{\text{modulation}}} L(\Delta f) d\Delta f} \quad (23)$$

Any phase noise above  $\Delta f > B_{\text{modulation}}$  is filtered away by the channel filter in the receiver. Further it is assumed that the carrier-recovery circuit of the receiver is able to track slow frequency and/or phase changes below  $\Delta f < B_{\text{carrier-recovery}}$ .

In digital communications, phase noise manifests itself as clock jitter. The unwanted clock jitter (root-mean-square value) can be calculated as:

$$\sigma_t = \frac{\sigma_{\phi}}{\omega_0} = \frac{1}{2\pi f_0} \sqrt{2 \int_{B_{\text{clock-recovery}}}^{f_{\text{MAX}}} L(\Delta f) d\Delta f} \quad (24)$$

Limiting the bandwidth of the clock, the upper limit  $f_{\text{MAX}} < f_0$  is less than the clock frequency. Further it is assumed that the clock-recovery circuit of the receiver is able to track slow frequency and/or phase changes below  $\Delta f < B_{\text{clock-recovery}}$ .

Finally in all radio communications, phase noise causes interference to neighbor channels. The interference power can be calculated as:

$$P_i = P_0 \cdot \int_{\Delta f_1}^{\Delta f_2} L(\Delta f) d\Delta f \quad (25)$$

The frequency limits  $\Delta f_1$  and  $\Delta f_2$  of the integral are the frequency offsets of the interfered channel from the interfering carrier  $P_0(f_0)$ .

Note that all of the above-mentioned integrals start from an offset  $\Delta f > 0$  larger than zero. Radio equipment is usually designed to work with relatively clean sources where the phase-noise power  $P_{N\phi} \ll P_0$  is much smaller than the carrier power and the Leeson's equation is valid thanks to  $L(\Delta f) \ll \Delta f^{-1}$  in the region of interest.

## Active-device noise

Besides thermal noise, active devices also add flicker noise to the amplified signal. Flicker noise is usually described as an increase of the radio-frequency noise figure  $F$  into a frequency-dependent noise figure  $F'(f)$ :

$$F'(f) = F \cdot \left(1 + \frac{f_c}{f}\right) \quad (26)$$

The parameter describing flicker noise is the corner frequency  $f_c$ . The latter depends on the device technology. Surface semiconductor devices like a silicon MOSFET, a GaAs MESFET or a GaAlAs HEMT may have the corner frequency

in the range  $f_c \approx 1 \dots 10 \text{ MHz}$ . Bulk semiconductor devices like a silicon BJT or a silicon JFET may have the corner frequency in the range  $f_c \approx 1 \dots 10 \text{ kHz}$ .

Although a HEMT may produce slightly less noise at radio frequencies than a BJT, a HEMT is significantly noisier at low frequencies than a BJT as shown on Fig. 5:

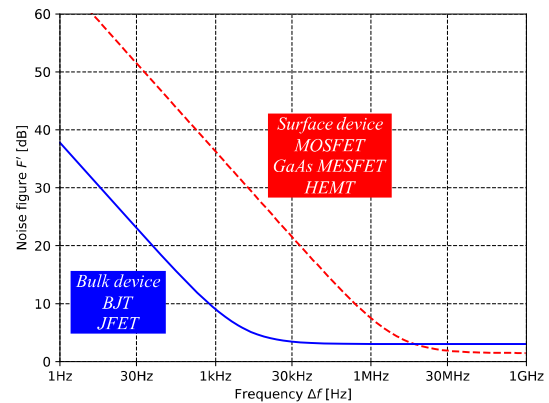


Figure 5: Active device noise figure.

In an oscillator, the active device operates in saturation while producing steady oscillations. The nonlinear effects associated with saturation up-convert the low-frequency flicker noise into noise side bands very close to the carrier radio frequency. High-performance radio-frequency (microwave) oscillators therefore use silicon bipolar transistors due to their lower flicker noise.

The additional up-converted flicker noise can be built into the Leeson's equation describing the increase the oscillator phase noise at small offsets  $|\Delta f| < f_c$ :

$$L(\Delta f) = \left[1 + \left(\frac{f_0}{2Q_L \Delta f}\right)^2\right] \cdot \frac{k_B T_0 F}{2P_0} \cdot \left(1 + \frac{f_c}{|\Delta f|}\right) \quad (27)$$

The phase noise of the same oscillator example as shown earlier including flicker noise is shown on Fig. 6:



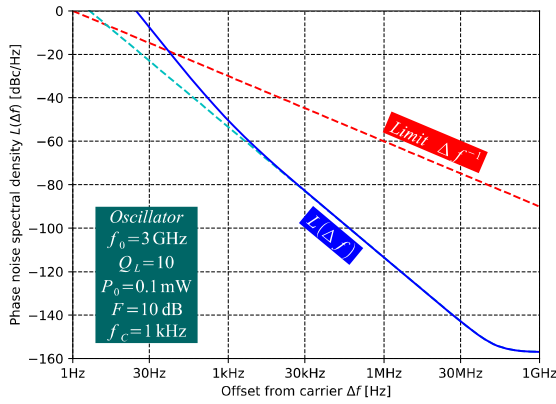


Figure 6: Phase noise including flicker noise. Calculations including flicker noise may not be simple. Calculating the flicker-noise power  $P_N$  from equation (26):

$$P_N = \int_{f_{MIN}}^{f_{MAX}} k_B \cdot F \cdot \left(1 + \frac{f_c}{f}\right) df \quad (28)$$

may give an infinite result:

$$\lim_{f_{MIN} \rightarrow 0} \int_{f_{MIN}}^{f_{MAX}} k_B \cdot F \cdot \left(1 + \frac{f_c}{f}\right) df \rightarrow \infty \quad (29)$$

suggesting that further limitations apply to (26) at very low frequencies.

Further it is necessary to understand that the flicker-noise corner frequency  $f_c$  in equation (26) is different from the  $f_c$  in equation (27)! Between the two quantities there is a frequency conversion that may be more or less efficient depending on parameters that are NOT described by the Leeson's equation!

The phase noise of an oscillator depend heavily on the bias and DC decoupling circuits. Since the impedance parameters  $[Z_{ij}]$  of a bipolar transistor depend mainly on the DC currents through the device, the currents through the RF amplifier transistor have to be regulated as constant as possible with a bias circuit like that on Fig. 7 [3]. Keeping the impedance parameters  $[Z_{ij}]$  constant attenuates the up-conversion of low-frequency flicker noise to the RF carrier frequency:

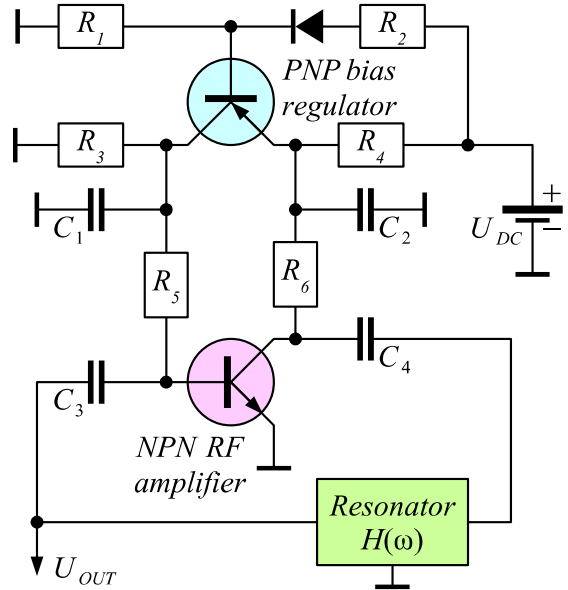


Figure 7: Oscillator bias circuit.

Flicker noise is not the only concern while designing the bias network of an oscillator. To avoid additional unwanted modes of the resonator  $H(\omega)$ , RF chokes (inductors) usually have to be replaced with resistors  $R_5$  and  $R_6$ .

Besides the RF feedback there is yet another feedback circuit built into every electronic oscillator. Gain reduction at saturation during steady oscillation is governed by this additional feedback (bottom graph on Fig. 2). A poorly-designed bias network will make this low-frequency feedback unstable causing self-quenching of the oscillator. While self-quenching may be desirable in a super-regenerative receiver (Armstrong 1922), it has a catastrophic effect on the oscillator spectrum.

The gain-reduction feedback already has one pole due to the RF energy stored in the resonator  $H(\omega)$ , rectified by the nonlinear effects of the saturation of the active device and added to the DC bias of the latter. Additional poles are added by the RF bypass capacitors  $C_1$  and  $C_2$  and by the DC-bias decoupling capacitors  $C_3$  and  $C_4$ . Unless the component values on Fig. 7 are selected carefully, the oscillator will be self-quenching. Even if the oscillator is not self-quenching, a poor phase margin of the bias feedback may cause a significant increase of the oscillator phase noise.

If varactors are used to tune the oscillator (VCO) [5], the phase noise is degraded further. First, varactors decrease the  $Q_L$  of the resonator due to their series resistance. Second, the tuning voltage may introduce additional noise. Even the noise voltage introduced by the resistors acting as RF chokes to tune the varactors is not insignificant.

## Spectral-line width

The Leeson's equation (19) is unable to describe the frequency spectrum of an oscillator very close to its central frequency  $\omega_0$  or  $f_0$  when the condition  $L(\Delta f) \ll \Delta f^{-1}$  is no longer fulfilled. Although there are several comprehensive papers on this topic like [4], [5], a simplified derivation is given here.

Analyzing Fig. 1, the feedback gain has to be slightly less than unity during steady oscillation, since some noise is being added all of the time. Accordingly, the original Barkhausen criterion (2) has to be modified to:

$$A \cdot H(\omega_0) = 1 - \epsilon \quad (30)$$

where the gain decrease is described by the very small, but non-zero quantity  $0 < \epsilon \ll 1$ . The feedback transfer function (10) is modified to:

$$A \cdot H(\omega) = \frac{1 - \epsilon}{1 + j 2 Q_L \frac{\Delta \omega}{\omega_0}} \quad (31)$$

resulting in equation (11) extended to:

$$U_{Nout} = \frac{U_{Nin}}{1 - A \cdot H(\omega)} \approx \frac{U_{Nin}}{1 - \frac{1 - \epsilon}{1 + j 2 Q_L \frac{\Delta \omega}{\omega_0}}} \rightarrow$$

$$\rightarrow U_{Nout} \approx U_{Nin} \cdot \frac{1 + j 2 Q_L \frac{\Delta \omega}{\omega_0}}{j 2 Q_L \frac{\Delta \omega}{\omega_0} - \epsilon} \quad (32)$$

At frequency offsets  $|\Delta f| > f_0/(2Q_L)$  larger than the Leeson's frequency, the oscillator has little effect on the noise while other circuits add their own noise. It therefore makes sense to evaluate (32) at small offsets  $|\Delta f| < f_0/(2Q_L)$  only. Considering  $|j 2 Q_L \Delta \omega / \omega_0| \ll 1$ , equation (32) simplifies to:

$$U_{Nout} \approx \frac{U_{Nin}}{j 2 Q_L \frac{\Delta \omega}{\omega_0} - \epsilon} \quad (33)$$

Replacing noise voltages with average powers, replacing angular frequencies with ordinary frequencies and considering the phase noise only:

$$P_{N\phi} = \frac{P_{Nout}}{2} \approx \frac{P_{Nin}/2}{\left(2 Q_L \frac{\Delta f}{f_0}\right)^2 + \epsilon^2} \quad (34)$$

Introducing the thermal-noise spectral density (15) or (16) and the spectral-line half width:

$$f_{HW} = \frac{\epsilon f_0}{2 Q_L} \quad (35)$$

the simplified Leeson's equation (21) evolves into a Lorentzian spectral line:

$$L(\Delta f) = \left(\frac{f_0}{Q_L}\right)^2 \cdot \frac{1}{\Delta f^2 + f_{HW}^2} \cdot \frac{k_B T_0 F}{8 P_0} \quad (36)$$

The missing quantities  $f_{HW}$  or  $\epsilon$  can be calculated by summing the whole relative spectrum power:

$$\int_{-f_0}^{\infty} L(\Delta f) d\Delta f = 1 \quad (37)$$

In all practical cases the integral start may be replaced by  $-\infty$ , the error being smaller than neglecting far-away thermal noise:

$$\int_{-\infty}^{\infty} \left(\frac{f_0}{Q_L}\right)^2 \cdot \frac{1}{\Delta f^2 + f_{HW}^2} \cdot \frac{k_B T_0 F}{8 P_0} d\Delta f =$$

$$= \left(\frac{f_0}{Q_L}\right)^2 \cdot \frac{k_B T_0 F}{8 P_0} \left[ \frac{1}{f_{HW}} \cdot \arctan \frac{\Delta f}{f_{HW}} \right]_{\Delta f = -\infty}^{\Delta f = \infty} =$$

$$= \left(\frac{f_0}{Q_L}\right)^2 \cdot \frac{k_B T_0 F}{8 P_0} \cdot \frac{\pi}{f_{HW}} \approx 1 \quad (38)$$

The spectral-line half width is obtained as:

$$f_{HW} \approx \pi \cdot \left(\frac{f_0}{Q_L}\right)^2 \cdot \frac{k_B T_0 F}{8 P_0} \quad (39)$$

The small correction of the Barkhausen criterion is:

$$\epsilon \approx \frac{\pi f_0 k_B T_0 F}{4 Q_L P_0} \quad (40)$$

Analyzing the same oscillator example with  $f_0 = 3 \text{ GHz}$ ,  $Q_L = 10$ ,  $P_0 = 0.1 \text{ mW}$  and  $F = 10 \text{ dB}$  as on Fig. 3 and Fig. 4, a spectral-line half width of  $f_{HW} \approx 14 \text{ Hz}$  is obtained. The corresponding correction of the Barkhausen criterion is small indeed  $\epsilon \approx 10^{-7}$ . One side band of the calculated spectrum  $L(\Delta f)$  is shown on Fig. 7 in logarithmic scale:

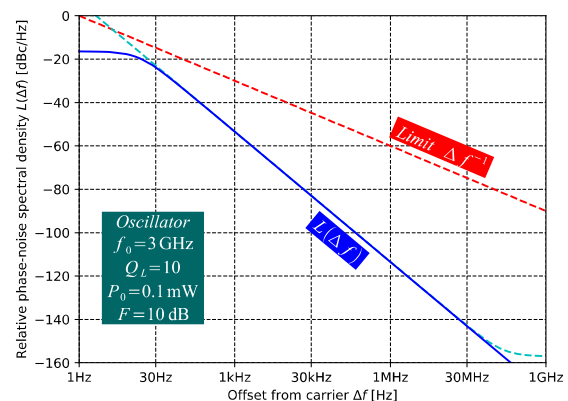


Figure 7: Lorentzian spectral line.

The result of the original Leeson's equation is plotted with a dotted line on the same graph as well as the  $\Delta f^{-1}$  limit. Note that at small offsets

the spectrum  $L(\Delta f)$  flattens thus avoiding the  $\Delta f^{-1}$  limit.

Besides thermal noise, additional noise like flicker noise further broadens the spectral line. The calculation is more difficult since the low-frequency flicker-noise spectrum is not up-converted by a single carrier frequency but by the oscillator signal itself with non-zero spectral width.

In most cases the spectral-line half width remains much narrower  $f_{HW} \ll B_{recovery}$  than the carrier or clock recovery circuits in radio equipment. In all these frequent cases the result of the original Leeson's equation is sufficient.

### Delay-line oscillators

The most important parameter in the Leeson's equation is the loaded quality  $Q_L$  of the resonator. Unfortunately electrical resonators in the radio-frequency range do not achieve very high values of  $Q_L$ . Mechanical resonators like quartz crystals are frequently used in high-performance radio oscillators. Electrical resonators may achieve very high values of  $Q_L$  in the optical-frequency range. Lasers may produce relatively very narrow spectral lines. Unfortunately dividing optical frequencies down to radio frequencies is not practical yet.

Delay lines may act as resonators in oscillator circuits. Their equivalent  $Q_{LD}$  is directly proportional to the delay  $\tau_D$  and increases linearly with frequency:

$$Q_{LD} = \pi f_0 \tau_D \quad (41)$$

Unfortunately delay lines may fulfill the Barkhausen criterion (2) at many different frequencies causing a laser to oscillate on many different modes. Lasers may use frequency-selective mirrors or gain medium to decrease the number of modes.

A similar approach may be used to design radio-frequency oscillators using either acoustic (BAW or SAW) delay lines or opto-electronic delay lines [6]. The latter look promising due to the low loss and wide bandwidth of optical fibers. The basic design of an opto-electronic oscillator is shown on Fig. 8. The desired mode of oscillation is selected by an additional electric (microwave) resonator:

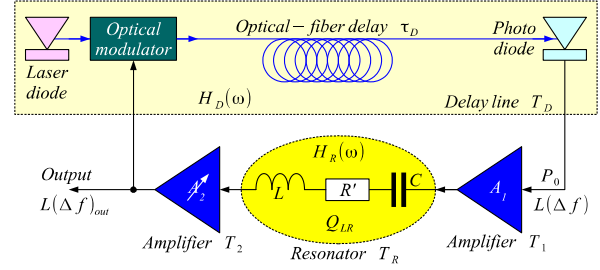


Figure 8: Opto-electronic oscillator.

The Barkhausen criterion (2) can be rewritten for the circuit on Fig. 8 as:

$$A_1 \cdot H_R(\omega_0) \cdot A_2 \cdot H_D(\omega_0) = 1 \quad (42)$$

If the electric resonator is tuned precisely to the desired mode of the delay line, the voltage transfer function of the latter can be written as:

$$H_D(\omega) = a \cdot e^{-j\Delta\omega\tau_D} \quad (43)$$

For small signals and small offsets:

$$A_1 \cdot H_R(\omega) \cdot A_2 \cdot H_D(\omega) = \frac{e^{-j\Delta\omega\tau_D}}{1 + j2Q_{LR}\frac{\Delta\omega}{\omega_0}} \quad (44)$$

The noise-voltage transfer function becomes:

$$U_{Nout} \approx \frac{U_{Nin}}{1 - \frac{e^{-j\Delta\omega\tau_D}}{1 + j2Q_{LR}\frac{\Delta\omega}{\omega_0}}} \quad (45)$$

The corresponding phase-noise average power is:

$$P_{N\phi} \approx \frac{P_{Nin}}{2} \left| 1 - \frac{e^{-j\Delta\omega\tau_D}}{1 + j2Q_{LR}\frac{\Delta\omega}{\omega_0}} \right|^{-2} \quad (46)$$

Finally the extended Leeson's equation for the opto-electronic oscillator shown on Fig. 8 becomes:

$$L(\Delta f) = \frac{k_B \sum T_j}{2P_0} \left| 1 - \frac{e^{-j2\pi\Delta f\tau_D}}{1 + j2Q_{LR}\frac{\Delta f}{f_0}} \right|^{-2} \quad (47)$$

The largest contribution to  $\sum T_j$  comes from the opto-electronic delay line that may include flicker noise:

$$\sum T_j \approx T_D \left( 1 + \frac{f_c}{|\Delta f|} \right) \quad (48)$$

In an opto-electronic oscillator as on Fig. 8 the most vulnerable point in the circuit is the photo-diode output. Here the signal power  $P_0$  is the lowest and the relative phase-noise spectral density  $L(\Delta f)$  is calculated. Saturation will likely be achieved in  $A_2$  since optical modulators require substantial amounts of RF drive power. The output  $L(\Delta f)_{out}$  is taken after all amplification and filtering:



$$L(\Delta f)_{out} \approx \frac{L(\Delta f)}{1 + \left(2Q_{LR} \frac{\Delta f}{f_0}\right)^2} \quad (49)$$

The analytical result for  $L(\Delta f)_{out}$  is fitted to the well-documented experimental data from [7]. The latter describes a microwave  $f_0=3\text{GHz}$  opto-electronic oscillator with the delay line made from  $l \approx 15\text{km}$  of optical fiber resulting in a delay of  $\tau_D \approx 75\mu\text{s}$  corresponding to a  $Q_{LD} \approx 7 \cdot 10^5$ . Mode selection is performed by an additional microwave dielectric resonator with the  $Q_{LR} \approx 8300$ .

The opto-electronic delay line noise temperature is found as expected around  $T_D \approx 2 \cdot 10^5\text{K}$ . What really matters is the ratio  $T_D/P_0$  and the latter can be measured conveniently at the output of a PIN-FET module. Flicker noise comes at least in part from the built-in HEMT amplifiers. Due to the high noise contribution from the opto-electronic delay line, the overall flicker-noise corner frequency is found around  $f_c \approx 5\text{kHz}$ .

The fitted analytical result for  $L(\Delta f)_{out}$  shown on Fig. 9 shows the unwanted side modes at the correct frequencies. However, the peak magnitudes of the unwanted modes are about 15 dB stronger than the measured values. This may be due to an insufficient resolution of the phase-noise test setup:

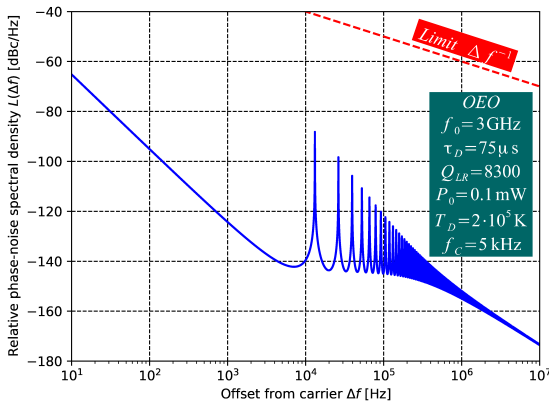


Figure 9: Simulated OEO phase noise.

The well-documented experimental data from [7] additionally includes results with a Q-multiplier circuit. The latter increases the loaded quality of the microwave mode-selection filter to about  $Q_{LR} \approx 75000$  thus improving the rejection of unwanted modes. Since a Q multiplier is an active filter, the system noise temperature increases to about  $T_D \approx 5 \cdot 10^5\text{K}$ .

The fitted analytical result for  $L(\Delta f)_{out}$  including the Q multiplier is shown on Fig. 10. The unwanted-mode magnitudes are reduced and their

line widths are broader. Both frequencies and magnitudes are very close to the measured values in [7]:

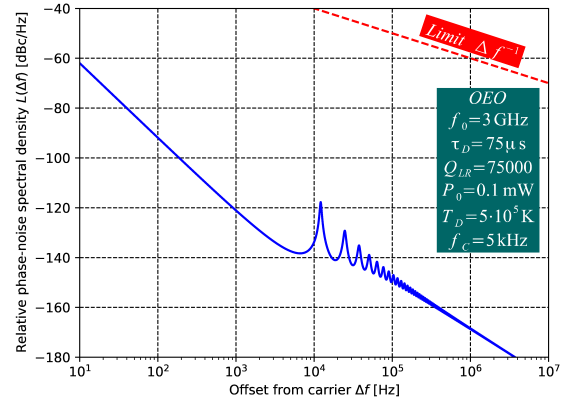


Figure 10: Simulated OEO with Q multiplier.

Finally, a parabolic approximation of the close-in response of a single microwave resonator suggests that the unwanted mode rejection is proportional to  $(Q_{LR})^4$ . For a Q-multiplication factor  $m \approx 8$  as described in [7], the unwanted-mode rejection improvement is expected as  $10 \log_{10} m^4 \approx 36\text{dB}$ . The difference between Fig. 9 and Fig. 10, corrected for the change in  $T_D$ , comes much closer to this value than the measured data published in [7], again suggesting an insufficient resolution of the phase-noise test setup.

## Conclusions

The Leeson's equation for relative phase-noise spectral density is frequently misunderstood and misused even in commercial simulation software. Therefore a complete derivation is made first to understand the limitations of the different forms of the same equation. While derivations produce results in linear units  $[\text{Hz}^{-1}]$ , logarithmic units  $[\text{dBc/Hz}]$  (20) are used elsewhere including the graphs in this article.

The complete Leeson's equation (19) is frequently simplified to (21), since wide-band thermal noise originates elsewhere and not just in the oscillator.

Flicker noise is usually built in the Leeson's equation like (27), but its exact magnitude actually depends on factors not included in the Leeson's equation, like the design of active-device bias networks. Last but not least, the simple  $1/f$  approximation of flicker noise may produce non-physical, infinite results in some cases.

The original Leeson's derivation is valid for small noise signals only. The result is only valid in the offset range when  $L(\Delta f) \ll \Delta f^{-1}$ . When

$L(\Delta f)$  approaches or even exceeds the  $\Delta f^{-1}$  limit, non-physical results are obtained. In the latter case a complete derivation of the oscillator spectrum has to be performed including the shape of the main spectral line of non-zero width. Flat thermal noise produces a Lorentzian spectrum (36).

Finally, the Leeson's equation is extended to delay-line oscillators and in particular opto-electronic oscillators. The extended equation (47) is fitted to experimental data showing potential problems of the latter.

As a conclusion of all of the above findings, an electronic oscillator is just a Q multiplier amplifying and filtering its own noise. The Q-multiplication factor is very large  $m \approx \epsilon^{-1}$  resulting in a very small, but non-zero spectral-line half width  $f_{HW} > 0$ . Besides bandwidth differences of many orders of magnitude, an electronic oscillator produces a similar signal to the spark radio transmitter or filtered white light in optics.

### Conflict of Interest

The author declares no conflict of interest.

The founding sponsors had no role in the design of the study; in the collection, analyses, or interpretation of data; in the writing of the manuscript, and in the decision to publish the results.

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